

Test Report No. : 10866733S-A
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Issued date : July 13, 2015
FCC ID : V9X-LMD400RC
Revised date : August 6, 2015

RADIO TEST REPORT

Test Report No.: 10866733S-A

Applicant : Circuit Design Inc.

Type of Equipment : UHF Narrow Band Multi Channel Transceiver

Model No. : LMD-400-R

Test regulation : FCC part 90 subpart I: 2015

FCC ID : V9X-LMD400RC

Test Result : Complied

- 1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the limits of the above standard.
- 4. The test results in this test report are traceable to the national or international standards.
- 5. This test report must not be used by the customer to claim product certification, approval, or endorsement by any agency of the Federal Government.
- 6. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.

Date of test: February 17 to 21, 2014

Representative test engineer:

Kenichi Adachi Engineer

Consumer Technology Division

Approved by:

Toyokazu Imamura Leader Consumer Technology Division

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REVISION HISTORY

Original Test Report No.: 10866733S-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	10866733S-A	July 13, 2015	-	-
1	10866733S-A	July 21, 2015	p.1, p.2 p.5, 8, 9,10,11	Revised report. Changed "TIA-603-C" to "TIA-603-D". Corrected the error in the table of section 3.2.
			p.11 p.32 - p.37	Added comments in section 9. Corrected the limit (+/-2.5 to +/-1.5).
2	10866733S-A	July 28, 2015	p.1, p.2 p.14	Revised report. Changed "TIA-603-C" to "TIA-603-D".
3	10866733S-A	August 6, 2015	p.14 p.1, p.2 p.5, p.13 p.15	Revised report. Added section 90.205, 90.267. Added comment in Emission masks data.

Shonan EMC Lab. 1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken 259-1220 JAPAN

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SECTION 1: Customer information

Company Name : Circuit Design Inc.

Address : 7557-1, Hotaka Azumino-city, Nagano 399-8303, Japan

Telephone Number : +81-263-82-1011 Facsimile Number : +81-263-82-1012 Contact Person : Maiko Yasunaga

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : UHF Narrow Band Multi Channel Transceiver

Model Number : LMD-400-R

Serial Number : Refer to Section 4.2 Rating : DC 3.0 V to 5.5 V

Country of Mass-production : Japan

Condition of EUT : Production model Receipt Date of Sample : February 7, 2014

Modification of EUT : The test lab did not make the modification to the EUT supplied from the customer to have it pass

the tests.

2.2 Product Description

Model: LMD-400-R (referred to as the EUT in this report) is a UHF Narrow Band Multi Channel Transceiver.

General Specification

Clock frequency(ies) in the system : 21.25 MHz

Radio Specification

Radio Type : Transceiver

Frequency of Operation : 458.0000 MHz to 462.5000 MHz

Modulation : GFSK

Intermediate frequency : 1st IF: 21.7 MHz, 2nd IF: 450 kHz

Bandwidth : 8.5 kHz
Channel spacing : 12.5 kHz
Power Supply (RF port input) : DC 3.0 V to 5.5 V
Antenna type : Whip antenna
Antenna Gain : 1.83 dBi

Antenna Connector Type : Plug connector (Shintake SP060022)

Operating Temperature : -20 deg.C to +60 deg.C

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SECTION 3: Test specification, procedures and results

3.1 Test Specification

Test specification : FCC Part 90 Subpart I: 2015, final revised on May 5, 2015

Title : FCC 47CFR Part90 PRIVATE LAND MOBILE RADIO SERVICES

* The revision on May 5, 2015 does not affect the test specification applied to the EUT.

3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	RF Output Power	TIA-603-D 2.2.1	FCC section 90.205, 90.217, 90.267	-	N/A	-	Complied
2	Modulation Characteristics	TIA-603-D 2.2.3, 2.2.6	FCC section 2.1033, RSS-119 section 5.2	-	N/A	-	Complied *3)
3	Emission Bandwidth	TIA-603-D 2.2.11, 1.3.4.4	FCC section 90.209, 90.217	-	N/A	-	(Complied) *4)
4	Emission masks	TIA-603-D 2.2.11, 1.3.4.4	FCC section 90.210, 90.217	-	N/A	-	(Complied) *4)
5	Spurious Emission at Antenna Terminals	TIA-603-D 2.2.13	FCC section 90.210, 90.215, 90.217	-	N/A	-	Complied
6	Field Strength of Spurious Emission	TIA-603-D 2.2.12	FCC section 90.210, 90.215, 90.217	Radiated	N/A	5.2 dB, (924.996 MHz, Horizontal, Peak, Tx 462.5 MHz)	Complied
7	Frequency Stability	TIA-603-D 2.2.2	FCC section 90.213, 90.217	-	N/A	-	(Complied) *4)
8	Transient Frequency Behavior	TIA-603-D 2.2.19	FCC section 90.214, 90.217	-	N/A	-	N/A *2)
9	Receiver spurious emissions	TIA-603-D 2.1.1	FCC 15.109, RSS-Gen 7	Radiated	N/A	29.5 dB, (484.200 MHz, Horizontal, QP, Rx 462.5 MHz)	(Complied) *4)
10	99% Occupied Bandwidth	RSS-Gen 4.6.1	RSS-Gen 4.6.1	-	N/A	N/A	N/A

Note: UL Japan, Inc.'s EMI Work Test Procedure 13-EM-W0420.

3.3 Addition to standard

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Confirmation

UL Japan, Inc. hereby confirms that E.U.T., in the configuration tested, complies with the specifications FCC part 90.

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^{*1)} These tests were also referred to "Land Mobile FM or PM Communications Equipment Measurement and Performance Standards" (TIA-603-D: 2010)

^{*2)} The test is not applicable since the power level of EUT is less than 120 mW.

^{*3)} The test is not applicable since this device is set to 2.4 kHz deviation as default value. To tuned up can not be made by end user. The procedure to tune up was attached when this application was submitted. Also, the modulation description as FCC section 2.1033(c)(13) requested was attached.

^{*4)} The test is not applicable since the power level of EUT is less than 120 mW, The test is reference.

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3.5 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k=2.

(EMI measurement)

Item	Frequency range	No.1 SAC*1 (±)	No.2 SAC(±)	No.3 SAC (±)
Radiated emission	9 kHz-30 MHz	3.7 dB	3.7 dB	3.6 dB
(Measurement distance: 3 m)	30 MHz-300 MHz	4.8 dB	5.0 dB	4.8 dB
	300 MHz-1 GHz	5.0 dB	5.0 dB	4.8 dB
	1 GHz-18 GHz	4.9 dB	4.9 dB	4.9 dB

(Substitution measurement)

Item	Frequency range	No.1 SAC*1 (±)	No.2 SAC(±)	No.3 SAC (±)
Radiated emission	30 MHz-300 MHz	4.7 dB	4.7 dB	4.7 dB
(Substitution measurement: 3 m)	300 MHz-1 GHz	3.7 dB	3.7 dB	3.7 dB
(EUT height 0.8 m)	1 GHz-18 GHz	5.3 dB	5.3 dB	5.3 dB

^{*1:} SAC=Semi-Anechoic Chamber

Radiated Emission Test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Power Measurement uncertainty above 1 GHz for this test was: (±) 1.5 dB

Conducted emissions Measurement (below 1 GHz) uncertainty for this test was: (±) 1.6 dB

Conducted emissions, Power Density Measurement (1 GHz-3 GHz) uncertainty for this test was: (±) 1.4 dB

Conducted emissions Measurement (3 GHz-18 GHz) uncertainty for this test was: (±) 2.8 dB

Frequency Measurement uncertainty for this test was: (\pm) 5.3 x 10^-6

Bandwidth Measurement uncertainty for this test was: (±) 5.4 %

3.6 Test Location

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Telephone number : +81 463 50 6400 Facsimile number : +81 463 50 6401 JAB Accreditation No. : RTL02610

Test room	Width x Depth x Height (m)	Test room	Width x Depth x Height (m)
No.1 Semi-Anechoic Chamber	20.6 x 11.3 x 7.65 Maximum measurement distance: 10m	No.1 Shielded room	6.8 x 4.1 x 2.7
No.2 Semi-Anechoic Chamber	20.6 x 11.3 x 7.65 Maximum measurement distance: 10m	No.2 Shielded room	6.8 x 4.1 x 2.7
No.3 Semi-Anechoic Chamber	12.7 x 7.7 x 5.35 Maximum measurement distance: 5m	No.3 Shielded room	6.3 x 4.7 x 2.7
No.4 Semi-Anechoic Chamber	8.1 x 5.1 x 3.55	No.4 Shielded room	4.4 x 4.7 x 2.7
		No.5 Shielded room	7.8 x 6.4 x 2.7
		No.6 Shielded room	7.8 x 6.4 x 2.7
		No.1 Measurement room	2.55 x 4.1 x 2.5

3.7 Data of EMI, Test instruments, Test set up

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

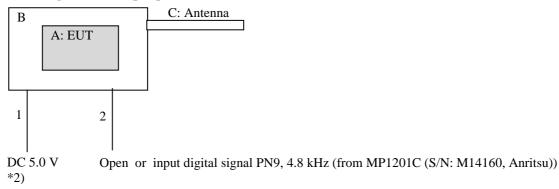
4.1 Operating Modes

Mode *1)	Tested frequency
Continuous Transmitting (Tx) None-modulated (CW)	458.0000 MHz, 462.5000 MHz
Continuous Transmitting (Tx) modulated	458.0000 MHz, 462.5000 MHz
Continuous Receiving (Rx)	458.0000 MHz, 462.5000 MHz

Justification

: The system was configured in typical fashion (as a customer would normally use it) for testing.

4.2. Configuration and peripherals



- *1) Cabling and setup were taken into consideration and test data was taken under worst case conditions.
- *2) DC power supply (Model No.: PAN35-10A) was used for DC 5.0 V input.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	UHF Narrow Band Multi Channel Transceiver	LMD-400-R	S0000019, *3) S0000020 *4)	Circuit Design Inc.	EUT
В	Test board	TB-STD-302/LMD- 400-R	-	Circuit Design Inc.	-
С	Whip antenna	ANT-LEA-01-R	1	Circuit Design Inc.	-

^{*3)} Used for Radiated emission tests.

List of cables used

No.	Name	Length (m)	Shio	Remark	
			Cable	Connector	
1	DC cable	1.3	Unshielded	Unshielded	-
2	Digital input	0.3	Shielded	Shielded	-

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^{*4)} Used for Antenna terminal conducted tests.

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SECTION 5: RF Output power

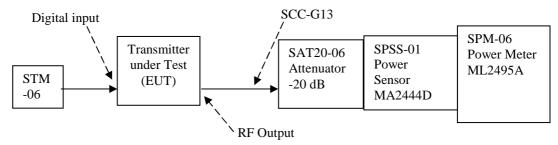
5.1 Test Procedure : TIA-603-D section 2.2.1

5.2 Test data : APPENDIX 1

5.3 Test result : Pass

5.4 Test instruments : SPM-06, SPSS-01, SAT20-06, SCC-G13, STM-06, KDC-01

5.5 Measurement Block Diagram of RF power output



RF Power Measurement (TIA-603-D section 2.2.1)

SECTION 6: Emission Bandwidth and Emission masks

6.1 Test Procedure : TIA-603-D section 2.2.11

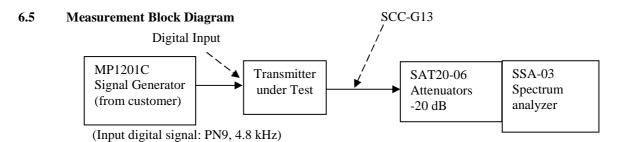
1) Set the reference level the spectrum analyzer to the unmodulation carrier level on the EUT

2) The Carrier is modulated by the PN9 digital signal (4.8 kHz) (worst mode). The input signal shall be established at the frequency of maximum response of the modulation. (*Emission mask D (406.1 MHz - 430 MHz and 450 MHz - 470 MHz, channel spacing: 12.5 kHz))

6.2 Test Data : APPENDIX 1

6.3 Test Result : Pass

6.4 Test Instrument : SSA-03, SCC-G13, SAT20-06, KDC-01, MP1201C



Emission Bandwidth (TIA-603-D section 2.2.11)

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SECTION 7: Spurious emission at Antenna Terminals

7.1 Test Procedure : TIA-603-D section 2.2.13

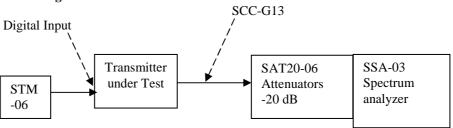
- 1) The EUT was aligned for transmitter operation at full rated power.
- 2) Set the reference level the spectrum analyzer to the unmodulation carrier level on the EUT. (Since spurious level was no difference between modulation mode and none-modulation mode)
- 3) Output of EUT was connected with spectrum analyzer through dummy load attenuator 20 dB.

7.2 Test Data : APPENDIX 1

7.3 Test result : Pass

7.4 Test Instrument : SSA-03, SCC-G13, SAT20-06, KDC-01

7.5 Measurement Block Diagram



Spurious Emission at Antenna Terminals (TIA-603-D section 2.2.13)

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SECTION 8: Field Strength of Spurious Emission

8.1 Test Procedure: TIA-603-D section 2.2.12

- 1) The EUT was aligned for transmitter operation at full rated power.
- 2) Set the reference level the spectrum analyzer to the unmodulation carrier level on the EUT. (Since spurious level was no difference between modulation mode and none-modulation mode)
- 3) Tune-up the transmitter (EUT)
- 4) For each spurious measurement the receiving antenna is adjusted to the correct length for the frequency involved. These measurements are made from the lowest radio frequency generated in the EUT or 30 MHz to the tenth harmonics of the carrier.
- 5) EUT was placed on a urethane plate form of nominal size, 0.5 m by 0.5 m raised 0.8 m above the conducting ground plane.
 - The Radiated Electric Field Strength intensity has been measured in semi anechoic chamber on a ground plane (above 1 GHz only) and at a distance of 3 m.
 - The measuring antenna height was varied between 1 m to 4 m and the turn table was rotated a full revolution in order to obtain the maximum value of the electric field strength.
 - The measurements were performed for both vertical and horizontal antenna polarization.
- Exchanged the EUT to the Substitution Antenna, the measurement was set for the same height 1.5 m as the EUT. The frequency below 1GHz of the Substitution Antenna was used the Half wave dipole Antenna, which was tuned the measured frequency in 1).
 - The frequency above 1GHz of the Substitution Antenna was used Horn Antenna.
 - The Substitution Antenna was connected to the Signal Generator, and the polarized electromagnetic radiation of the Substitution Antenna was matched with the one of the measuring Antenna, which was set with the Signal Generator to the measured frequency in 1). Then, we set with the Output power (CW) of the Signal Generator where the measuring electromagnetic field strength is equal to the measured value in 1) by means of varying the measuring antenna height between 1 m to 4 m to obtain maximum receiving level. Its Output power of Signal Generator was recorded.
- 7) Below 1 GHz:
 - Effective radiated power was calculated by subtracting the cable loss and the attenuator loss connected between the Signal Generator and the Substitution Antenna from the Output power of the Signal Generator recorded in 2).

For the usage of the Antenna (Horn Antenna) except for the Half wave dipole Antenna (2.15 dBi) for the Substitution Antenna, the Effective radiated power was calculated by compensating the finite difference in the Antenna gain of the Half wave dipole Antenna, and Substitution Antenna.

Above 1 GHz:

Equivalent isotropic radiated power was calculated by subtracting the cable loss and the attenuator loss connected between the signal generator and the substitution antenna from the output power of the signal generator recorded in 2).

For the usage of the antenna (horn antenna) for the substitution antenna, the equivalent isotropic radiated power was calculated by compensating the finite substitution antenna.

Frequency	Below 1 GHz	Above 1 GHz
Instrument used	Spectrum Analyzer	Spectrum Analyzer
IF Bandwidth	PK: RBW: 10 kHz/VBW: 300 kHz	PK: RBW: 1 MHz/VBW: 3 MHz

Transmitter Spurious Limit : Carrier Level [dBm] - 30 dB

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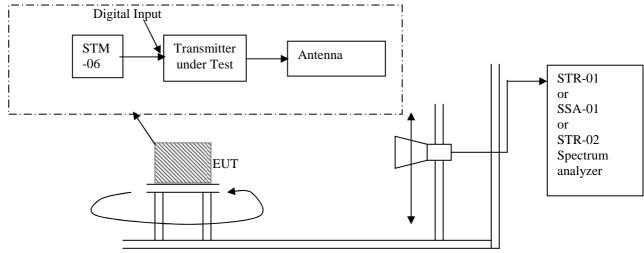
8.2 Test Data : APPENDIX 1

8.3 Test Result : Pass

8.4 Test Instrument:

[9k-30MHz]: SAEC-02, STR-02, SAF-02, SCC-B2/B4/B6/B7/B8/B13/SRSE-02, SAT6-07, SLP-02, [30M-1GHz]: SAEC-01, STR-01, SAF-01, SCC-A1/A3/A5/A7/A8/A13/SRSE-01, KAT6-04, SBA-01, SAT10-01, SCC-A2/A4/A6/A7/A8/A13/SRSE-01, KAT3-09, SLA-01, SSG-02, SCC-04, SCC-05, SDA-08 [1G-5GHz]: SAEC-02, SSA-01, SCC-G22, KAF-04, SCC-G02, SHA-02, SSG-02, SCC-G16, SHA-RS01

8.5 Measurement Block Diagram



Field Strength of Spurious Emission (TIA-603-D section 2.2.12)

SECTION 9: Frequency Stability

9.1 Test Procedure : TIA-603-D section 2.2.2

* The limit value applied +/-1.5 ppm of severest "Fixed", because the tested equipment cannot specify either of Fixed or Mobile.

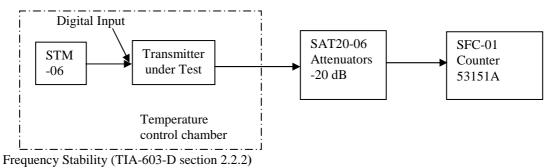
*It is originally necessary to measure -30 deg.C to +50 deg.C, but -30 deg.C was not measured, because this test may be not applied since the RF output power of this equipment is less than 120 mW.

9.2 Test Data : APPENDIX 1

9.3 Test Result : Pass

9.4 Test Instrument : SCH-01, SFC-01, SAT20-06, SCC-G13, KDC-01, MP1201C

9.5 Measurement Block Diagram



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APPENDIX 1: Data of Radio tests

RF output power

Emissions Bandwidth

Emissions masks

Spurious emission at antenna terminal

Radiated Emission Test (Field Strength of Spurious Emission)

Radiated Emission Test (Receiver spurious emissions)

Frequency stability

APPENDIX 2: Test instruments

Test instruments

APPENDIX 3: Photographs of test setup

Radiated emission

Antenna terminal conducted tests

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APPENDIX 1: Data of Radio tests RF output power

UL Japan, Inc.

Date

Shonan EMC Lab. No.5 Shielded Room

Circuit Design Inc. Company

Equipment UHF Narrow Band Multi Channel Transceiver

Model LMD-400-R

Serial No. S0000020 DC 5 V Power

Mode

Transmitting

FCC section 90.217 Regulation

FCC section 90.205, 90.267

RSS-119, section 5.10

February 20, 2014

Temperature 24 deg.C Humidity 52 %RH

ENGINEER Kenichi Adachi

(* P/M: Power Meter with power sensor, PK: Peak, AV: Average)

Freq.	P/M (PK)	Cable	Atten.	Res	sult	Li	mit	Margin
	Reading	Loss	Loss					
[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
458.0000	-11.12	1.59	19.89	10.36	10.86	20.79	120.00	10.43
462.5000	-11.74	1.59	19.89	9.74	9.42	20.79	120.00	11.05

^{*} Reference limit: 6 W e.r.p. (for fixed or mobile), 2 W e.r.p. (for portable) (section 90.267(e)(2), 90.267(g)(2))

(Reference)

Maximum permissible exposure (MPE)

For the calculation of the MPE, a reference antenna with a gain of 1.83 dBi (= 1.52) has been assumed.

Freq.	Max power	Antenna	Power	Power	Limit1	Limit2
		Gain	density	density		
			at 20 cm	at 20 cm		
[MHz]	[mW]	[]	[mW/cm^2]	[W/m^2]	[mW/cm^2]	[W/m^2]
						[, ===]
458.0000	10.86	1.52	0.003	0.033	0.305	1.724

Calculation:

Power density at 20 cm $[mW/cm^2] = (Max power [mW] x Antenna gain [])/(4 x pi x (r = 20 [cm])^2)$

Power density at 20 cm $[W/m^2]$ = Power density at 20 cm $[mW/cm^2]$ x 10

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^{*} Limit1 for maximum permissible exposure (MPE) according to FCC 1.1310 table1(b) (= f [MHz] /1500)

^{*} Limit2 for maximum permissible exposure (MPE) according to RSS-102 section 4 and Safety Code 6 section 2.2 table 6 (= 0.02619 x f [MHz] ^ (0.6834))

Revised date : July 28, 2015

Emission Bandwidth

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company Circuit Design Inc.

Equipment UHF Narrow Band Multi Channel Transceiver

Model LMD-400-R

Serial No. S0000020
Power DC 5 V
Mode Transmitting

input signal: PN9, 4.8 kHz (worst data (Digital signal))

Regulation FCC part 90, section 90.209

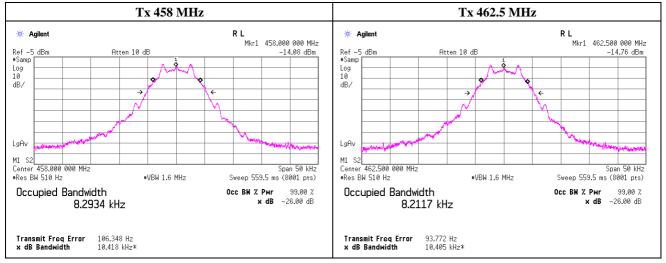
RSS-119, section 5.5, table 3

Date February 20, 2014

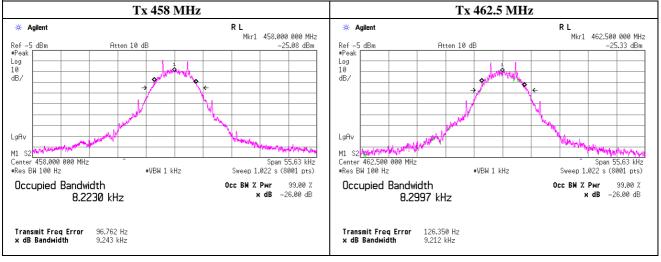
Temperature 24 deg.C Humidity 52 %RH ENGINEER Kenichi Adachi

Freq.	(Reference) 26 dB bandwidth	99 % Occupied bandwidth
[MHz]	[kHz]	[kHz]
458.0000	9.2430	8.2934
462.5000	9.2120	8.2117

(method RSS-Gen)



(method TIA-603-D)



UL Japan, Inc.

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Emission masks

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company Circuit Design Inc.

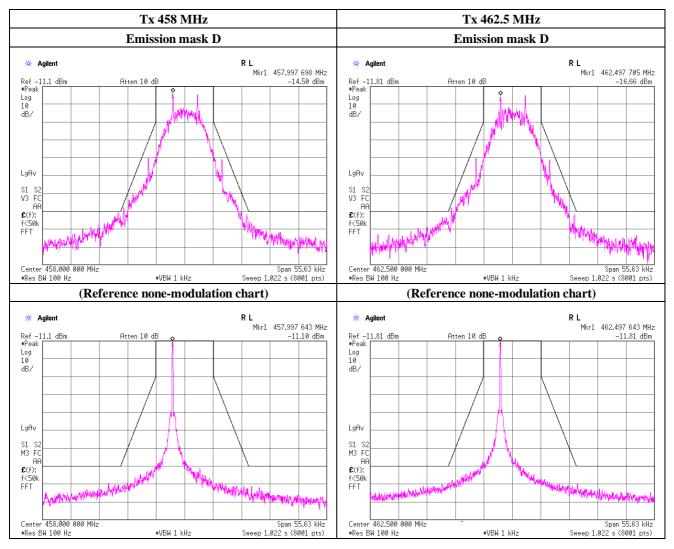
Equipment UHF Narrow Band Multi Channel Transceiver

Model LMD-400-R Serial No. S0000020 Power DC 5 V Mode Transmitting

input signal: PN9, 4.8kHz (worst data (Digital signal))

Regulation FCC part 90, section 90.210 RSS-119, section 5.8.3 Date February 20, 2014

Temperature 24deg.C Humidity 52%RH ENGINEER Kenichi Adachi



^{*} Limit line is

 $center\ frequency\ to\ +/-5.625\ kHz\ (=width\ 11.25\ kHz)\ is\ -0\ [dB],\ +/-5.625\ kHz\ to\ +/-12.5\ kHz\ is\ -(7.27\ *(fd\ -2.88))\ [dB]\ and\ +/-12.5\ kHz\ outside\ is\ -70\ [dB].$

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Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

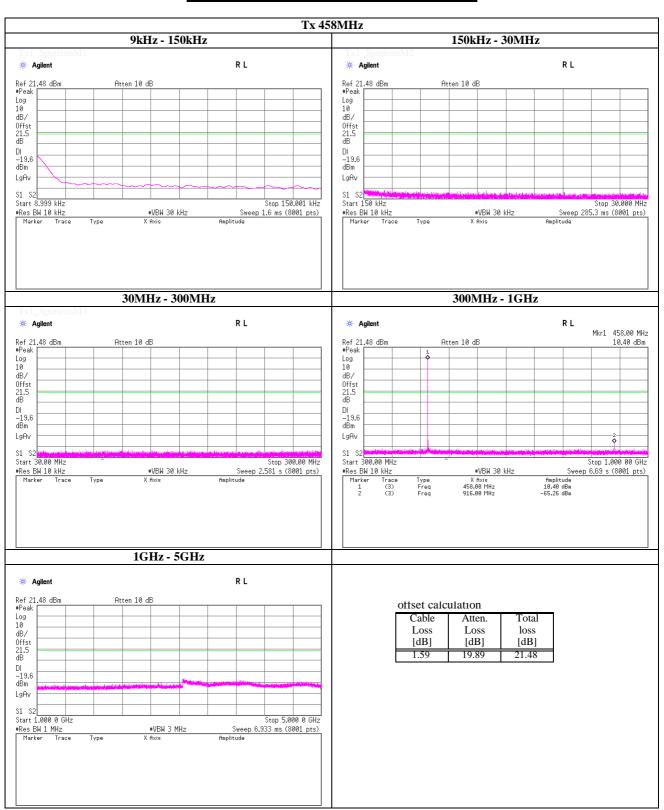
^{*} Although Span was set narrower than real measurement value(56.25 kHz) by equipment setting, these limits was severer than real limits line.

^{*} It was originally only that was the limit of -30 dB of 90.217, however, the severe of limit of RSS-119 / FCC 90.210 was used.

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room
Date February 20, 2014 (Serial No. S0000020)

 $\begin{array}{ll} Temperature \, / \, Humidity & 24 deg. C & , 52\% \, RH \\ Engineer & Kenichi \, Adachi \end{array}$

Spurious emission at antenna terminal



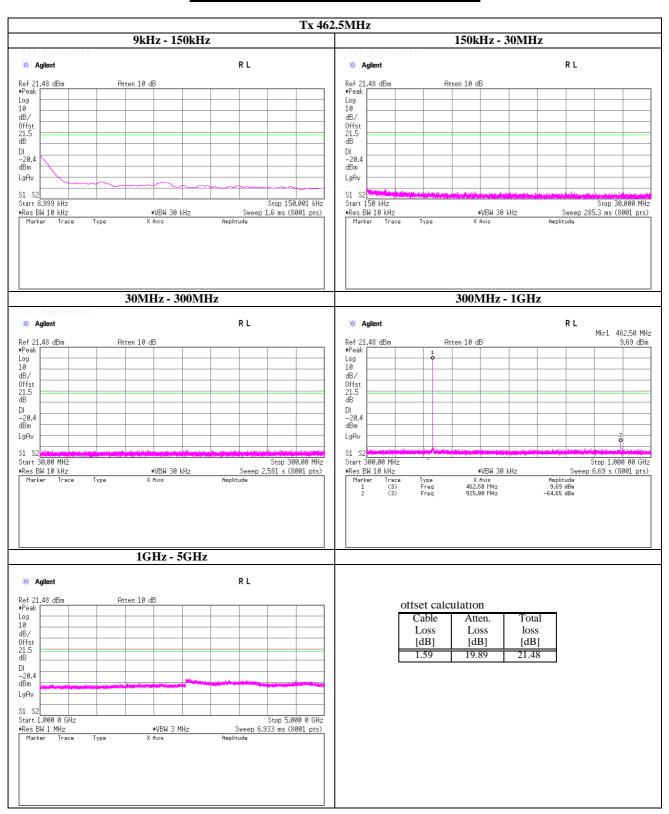
UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room
Date February 20, 2014 (Serial No. S0000020)

 $\begin{array}{ll} Temperature \, / \, Humidity & 24 deg. C & , 52\% \, RH \\ Engineer & Kenichi \, Adachi \end{array}$

Spurious emission at antenna terminal



UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

DATA OF RADIATED EMISSION (below 30MHz) TEST

UL Japan,Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date: 2014/02/20

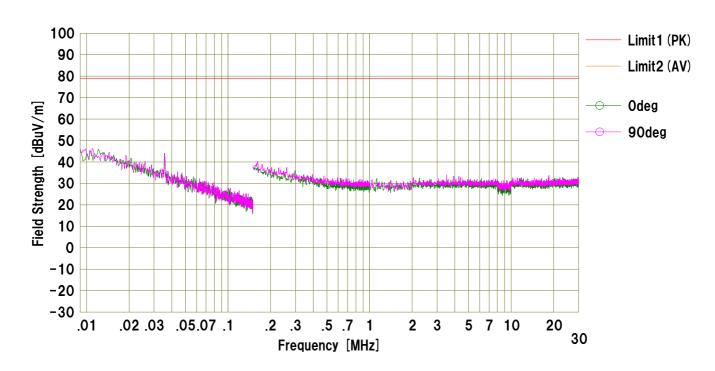
Circuit Design, Inc. Mode

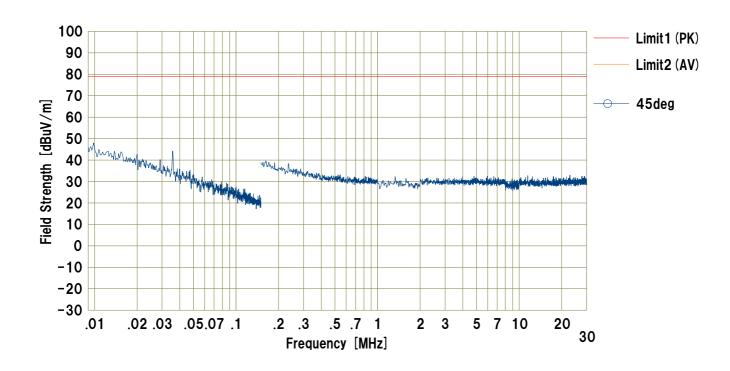
Company Kind of EUT Transmitting 458.0000MHz 10214948S DC 5V UHF Narrow band multi channel transceiver Order No. Model No.

LMD-400-R Power S0000019 Temp./Humi. 24deg.C / 21%RH Serial No. Remarks EUT & antenna worst-axis: Y

No detect signal from EUT

Limit1: FCC part 90, carrier level=108.9dBuV/m, Spurious, PK





DATA OF RADIATED EMISSION (below 30MHz) TEST

Mode

Power

UL Japan,Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date: 2014/02/20

10214948S DC 5V

24deg.C / 21%RH

Transmitting 462.5000MHz

Company Kind of EUT Circuit Design, Inc.

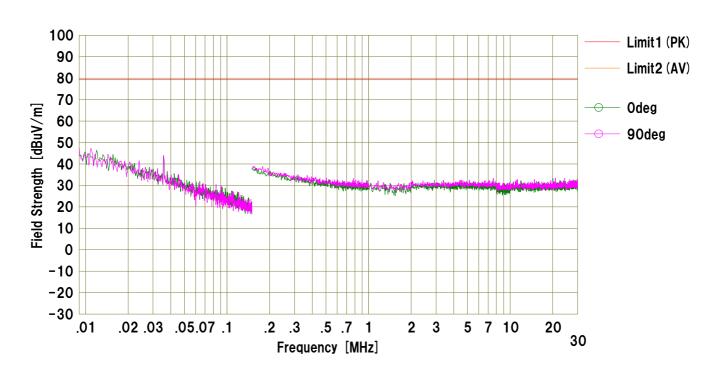
UHF Narrow band multi channel transceiver Order No.

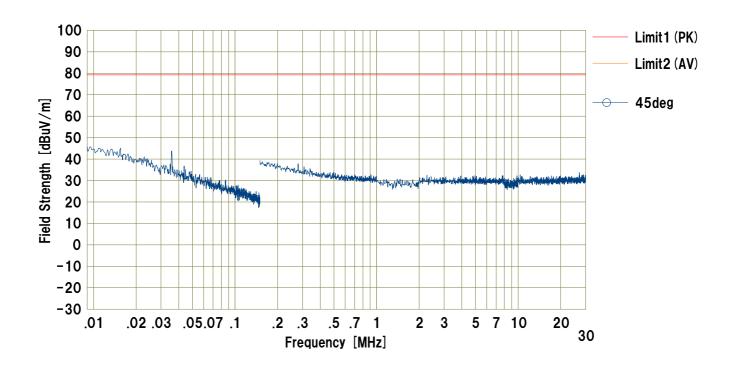
Model No. LMD-400-R S0000019 Serial No.

Remarks EUT & antenna worst-axis: Y No detect signal from EUT

Temp./Humi.

Limit1: FCC part 90, carrier level=109.2dBuV/m, Spurious, PK





DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.1 Semi-Anechoic Chamber Date : 2014/02/18

Circuit Design, Inc.

Company Kind of EUT Model No. UHF Narrow band multi channel transceiver LMD-400-R

50000019 Serial No.

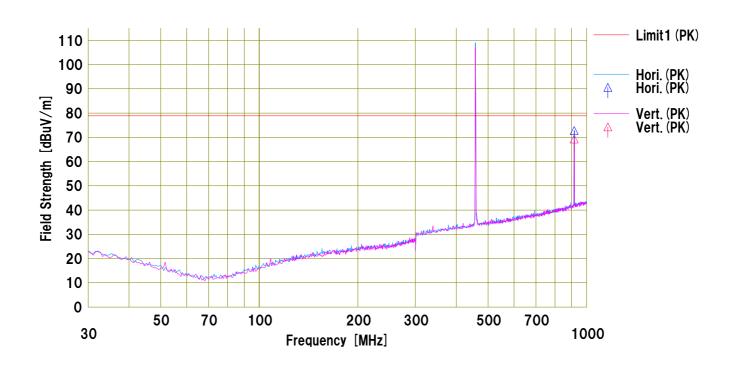
EUT & antenna worst-axis: H: Z, V: X Remarks

Transmitting 458.0000MHz 10214948S DC 5V Mode

Order No.

Power Temp./Humi. 21deg.C / 22%RH

Limit1: FCC part 90, carrier level=108.9dBuV/m, Spurious, PK



No.	Freq.	Reading <pk></pk>	Ant.Fac			Result <pk></pk>	Limit <pk></pk>	Margin <pk></pk>		Height		Ant. Type	Comment
	[MHz]	[dBuV]			[dB]		[dBuV/m]	[dB]	[H/V]		[deg]		
1	915.996					72.8			Hori.	100			
2	915.996	59.1	21.5	20.0	31.3	69.3	78.9	9.6	Vert.	100	0	LP	
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DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.1 Semi-Anechoic Chamber Date : 2014/02/18

Company Kind of EUT Model No. Circuit Design, Inc.

UHF Narrow band multi channel transceiver

LMD-400-R 50000019

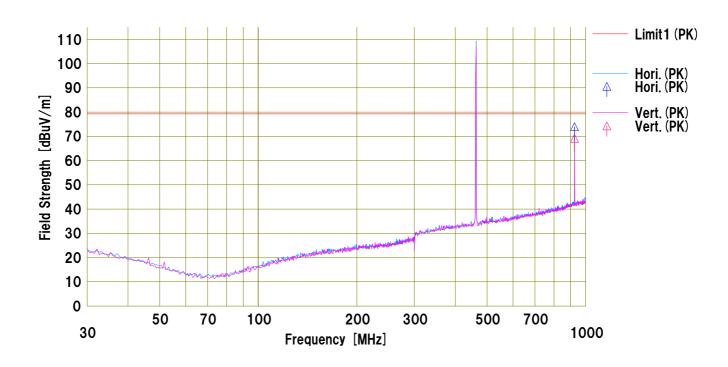
Serial No. EUT & antenna worst-axis: H: Z, V: X Remarks

Transmitting 462.5000MHz 10214948S DC 5V Mode

Order No. Power

Temp./Humi. 21deg.C / 22%RH

Limit1: FCC part 90, carrier level=109.2dBuV/m, Spurious, PK



No.	Freq.	Reading <pk></pk>	Ant.Fac	Loss	Gain	Result <pk></pk>	Limit <pk></pk>	Margin <pk></pk>	Pola.	Height	Angle	Ant. Type	Comment
'''	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]		[dBuV/m]	[dB]	[H/V]	[cm]	[deg]	Type	- Commont
1	924.996	63.7	21.5	20.0	31.2	74.0	79.2	5.2	Hori.	100	116	LP	
2	924.996	58.9	21.5	20.0	31.2	69.2	79.2	10.0	Vert.	100	0	LP	

DATA OF RADIATED EMISSION TEST

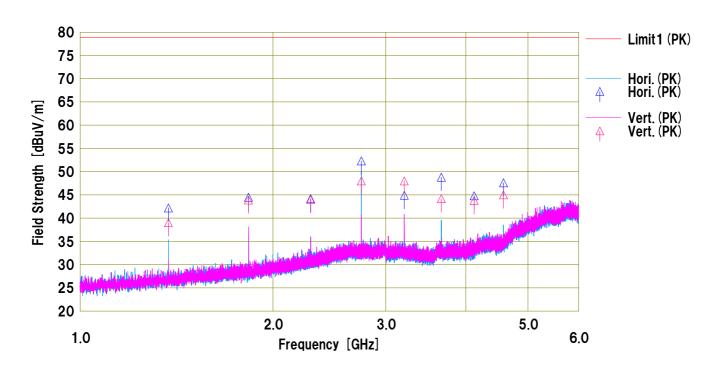
UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date : 2014/02/19

Circuit Design, Inc. Mode

Transmitting 458.0000MHz 10214948S DC 5V Company Kind of EUT Model No. UHF Narrow band multi channel transceiver Order No. LMD-400-R Power

50000019 Temp./Humi. 24deg.C / 21%RH Serial No. Remarks EUT & antenna worst-axis: H: Y, V: Z

Limit1: FCC part 90, carrier level=108.9dBuV/m, Spurious, PK



	Freq.	Reading	Ant.Fac	Loss	Gain	Result	Limit	Margin	Pola.	Height	Angle	Ant.	
No.	[MHz]	<pk> [dBuV]</pk>	[dB/m]		[dB]	<pk> [dBuV/m]</pk>	<pk> [dBuV/m]</pk>	<pk> [dB]</pk>	[H/V]	[cm]	[deg]	Туре	Comment
1	1373,993	50.2			36.0	42.2	78.9		Hori.	103	101	SHA02	
2	1831.992	50.5	1	3.7	35.4	44.5	78.9		Hori.	117		1	
3	2289.988	48.0	27.1	4.2	35.1	44.2	78.9	34.7	Hori.	122	62	SHA02	
4	2747.987	54.6	28.2	4.6	35.1	52.3	78.9	26.6	Hori.	100	66	SHA02	
5	3205.984	46.5	28.4	5.1	35.1	44.9	78.9	34.0	Hori.	103	61	SHA02	
6	3663.981	50.0	28.4		35.1	48.8	78.9	30.1	Hori.	108	66	SHA02	
7	4121.979	45.0	28.9		34.8	44.8	78.9	34.1	Hori.	100	65	SHA02	
8	4579.977	46.4			34.6	47.6	78.9	31.3	Hori.	100	301	SHA02	
9	1373.993	47.0	24.9		36.0	39.0	78.9	39.9	Vert.	152	289	SHA02	
10	1831.992	49.9	25.7	3.7	35.4	43.9	78.9	35.0	Vert.	151	231	SHA02	
11	2289.988	47.8		4.2	35.1	44.0	78.9			110		1	
12	2747.987	50.3		4.6	35.1	48.0	78.9			106	177	1	
13	3205.984	49.6			35.1	48.0	78.9			127	51		
14	3663.981	45.4			35.1	44.2	78.9		Vert.	131	34		
15	4121.979	44.0	1		34.8	43.8	78.9		Vert.	132	44		
16	4579.977	43.8	29.6	6.2	34.6	45.0	78.9	33.9	Vert.	131	0	SHA02	

DATA OF RADIATED EMISSION TEST

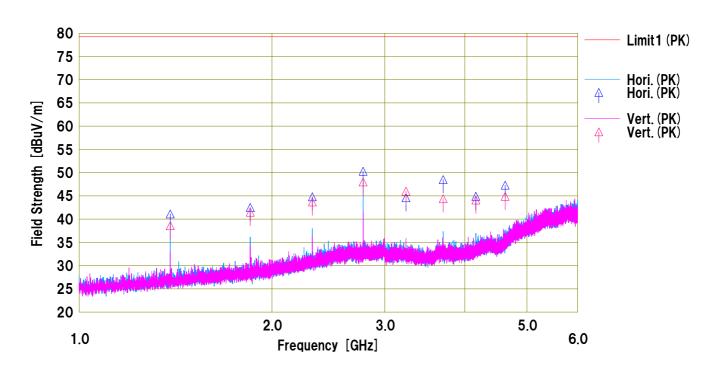
UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date : 2014/02/19

Circuit Design, Inc. Mode

Company Kind of EUT Model No. Transmitting 462.5000MHz 10214948S DC 5V UHF Narrow band multi channel transceiver Order No. LMD-400-R Power 50000019 Temp./Humi. 24deg.C / 21%RH Serial No.

Remarks EUT & antenna worst-axis: H: Y, V: Z

Limit1: FCC part 90, carrier level=109.2dBuV/m, Spurious, PK



	F	Reading	4			Result	Limit	Margin	D.1.				
No.	Freq.	<pk></pk>	Ant.Fac	Loss	Gain	<pk></pk>	<pk></pk>	<pk></pk>	Pola.	Height	Angle	Ant. Type	Comment
	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[H/V]	[cm]	[deg]	1,00	
1	1387.493	48.9	24.9	3.2	35.9	41.1	79.2	38.1	Hori.	104	100	SHA02	
2	1849.991	48.4	25.7		35.4	42.5	79.2	36.7	Hori.	115	106	SHA02	
3	2312.488	48.5	27.2	4.2	35.1	44.8	79.2	34.4	Hori.	121	60	SHA02	
4	2774.986	52.5			35.1	50.3	79.2	28.9	Hori.	100	65	SHA02	
5	3237.484	46.2	28.4		35.2	44.6	79.2	34.6	Hori.	102	62	SHA02	
6	3699.981	49.7			35.1	48.5	79.2		Hori.	107			
7	4162.479				34.8	44.9	79.2		Hori.	100		1	
8	4624.977	45.8			34.6	47.3	79.2		Hori.	100		SHA02	
9	1387.493				35.9	38.6	79.2		Vert.	149		SHA02	
10		47.4			35.4	41.5	79.2		Vert.	149		SHA02	
11	2312.488	47.4			35.1	43.7	79.2			109	62	1	
12					35.1	48.0	79.2	31.2		104	175	1	
13	3237.484	47.6			35.2	46.0	79.2		Vert.	147	64		
14	3699.981	45.6			35.1	44.4	79.2	34.8	Vert.	129	36	1	
15	4162.479	44.1			34.8	44.1	79.2		Vert.	133			
16	4624.977	43.4	29.9	6.2	34.6	44.9	79.2	34.3	Vert.	130	0	SHA02	

DATA OF RADIATED EMISSION (SUBSTITUTION)

UL Japan, Inc. Shonan EMC Lab. No.1 Semi-Anechoic Chamber Date : 2014/02/18

: Circuit Design, Inc.

Company Kind of EUT Model No. UHF Narrow band multi channel transceiver

: LMD-400-R : S0000019 Serial No.

EUT & antenna worst-axis: H: Z, V: X Remarks

Transmitting 458.0000MHz 10214948S DC 5V Mode

Order No.

Power : 21deg.C / 22%RH Temp./Humi.

Limit: FCC part 90, Substitution -13dBm, Spurious, PK

: Kenichi Adachi **Engineer**

<< ERP DATA >>

<u>``</u>													
	Freq.	Reading	SG Level	TX Ant.Gain	TX Loss	ER	P	Margin		Height	Angle	TV	
No.		<pk></pk>				Result	Limit		Pola.			TX Ant.Type	Comment
	[MHz]	[dBuV]	[dBm]	[dBi]	[dB]	[dBm]	[dBm]	[dB]		[cm]	[deg]		
1	915.996	62.6	-8.6	2.2	20.8	-29.4	-13.0	16.4	Hori.	100	115	Dipol	
2	915.996	59.1	-8.9	2.2	20.8	-29.7	-13.0	16.7	Vert.	100	0	Dipol	

DATA OF RADIATED EMISSION (SUBSTITUTION)

UL Japan, Inc. Shonan EMC Lab. No.1 Semi-Anechoic Chamber Date : 2014/02/18

: Circuit Design, Inc.: UHF Narrow band multi channel transceiver

Company Kind of EUT Model No. : UHF Narrow C : LMD-400-R : S0000019 Serial No.

EUT & antenna worst-axis: H: Z, V: X Remarks

Transmitting 462.5000MHz 10214948S DC 5V Mode

Order No. Power

: 21deg.C / 22%RH Temp./Humi.

Limit: FCC part 90, Substitution -13dBm, Spurious, PK

: Kenichi Adachi **Engineer**

<< ERP DATA >>

	LINF DATA												
	Freq.	Reading	SG Level	TX Ant.Gain	TX Loss	ER	P	Margin		Height	Angle	TY	
No.		<pk></pk>		Ant.Gain	Loss	Result	Limit		Pola.			TX Ant.Type	Comment
_	[MHz]	[dBuV]	[dBm]	[dBi]	[dB]	[dBm]	[dBm]	[dB]		[cm]	[deg]		
1	924.996	63.7	-7.6 -9.2	2.2 2.2	21.0	-28.6	-13.0	15.6	Hori.	100	116	Dipol	
2	924.996	58.9	-9.2	2.2	21.0	-30.2	-13.0	17.2	Vert.	100	0	Dipol	

DATA OF RADIATED EMISSION (SUBSTITUTION)

UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date: 2014/02/19

Company Kind of EUT Model No.

: Circuit Design, Inc. : UHF Narrow band multi channel transceiver

LMD-400-R Serial No. S0000019

: EUT & antenna worst-axis: H: Y, V: Z Remarks

Mode Order No. Transmitting 458.0000MHz

10214948S DC 5V Power

Temp./Humi. : 24deg.C / 21%RH

Limit: FCC part 90, Substitution -13dBm, Spurious, PK

Engineer : Kenichi Adachi

<< EIRP DATA >>

No.		PK>	1	Ant.Gain	Loss	Result	Limit	Margin	Pola.	Height	Angle	TX Ant.Type	Comment
[MH	z] [di	BuV]	[dBm]	[dBi]	[dB]	[dBm]	[dBm]	[dB]		[cm]	[deg]	Ant. Type	
	3.993	50.2	-63.0	7.2	4.7	-60.5	-13.0	47.5	Hori.	103	101	Horn	
2 183	1.992	50.5	-61.6	9.4	5.5	-57.7	-13.0	44.7	Hori.	117	104	Horn	
	9.988	48.0	-63.6	9.6	6.2	-60.2	-13.0	47.2	Hori.	122	62	Horn	
	7.987	54.6	-51.3	9.9	6.8	-48.2	-13.0	35.2	Hori.	100	66	Horn	
	5.984	46.5	-64.4	11.3	7.3	-60.4	-13.0	47.4	Hori.	103	61	Horn	
	3.981	50.0	-57.4	12.3	7.8	-52.9	-13.0	39.9	Hori.	108	66	Horn	
	1.979	45.0	-65.4	12.3	8.3	-61.4	-13.0	48.4	Hori.	100	65	Horn	
	9.977	46.4	-61.0	12.2	8.8	-57.6	-13.0	44.6	Hori.	100	301	Horn	
	3.993	47.0	-70.5	7.2	4.7	-68.0	-13.0	55.0	Vert.	152	289	Horn	
	1.992	49.9	-64.9	9.4	5.5	-61.0	-13.0	48.0	Vert.	151	231	Horn	
	9.988	47.8	-62.1	9.6	6.2	-58.7	-13.0	45.7	Vert.	110	59	Horn	
	7.987 5.984	50.3 49.6	-55.4 -58.3	9.9 11.3	6.8 7.3	-52.3 -54.3	-13.0 -13.0	39.3 41.3	Vert. Vert.	106 127	177 51	Horn	
l I	3.981	45.4	-56.3 -67.3		7.8	-54.3 -62.8	-13.0 -13.0	49.8	Vert.	131	34	Horn	
	1.979	44.0	-67.3 -69.8	12.3 12.3	8.3	-62.8	-13.0	52.8	Vert.	132	44	Horn Horn	
	9.977	43.8	-70.0	12.2	8.8	-66.6	-13.0	53.6	Vert.	131	77	Horn	
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DATA OF RADIATED EMISSION (SUBSTITUTION)

UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date: 2014/02/19

: Circuit Design, Inc. : UHF Narrow band multi channel transceiver

Company Kind of EUT Model No. LMD-400-R Serial No. S0000019

: EUT & antenna worst-axis: H: Y, V: Z Remarks

Mode Order No. Transmitting 462.5000MHz

10214948S DC 5V Power

Temp./Humi. : 24deg.C / 21%RH

Limit: FCC part 90, Substitution -13dBm, Spurious, PK

Engineer : Kenichi Adachi

<< EIRP DATA >>

<u>```</u>	LIIII DAIA												
	From	Reading	CO Love	TX Ant.Gain	TX	EIR	P	Marair		llaiak I	Angle	T V	
No.	Freq.	<pk></pk>	SG Level		Loss	Result	Limit	Margin	Pola.	Height	Angle	TX Ant.Type	Comment
	[MHz]	[dBuV]	[dBm]	[dBi]	[dB]	[dBm]	[dBm]	[dB]		[cm]	[deg]	AIII.13PC	
1	1387.493		-64.3	7.3	4.8	-61.8	-13.0		Hori.	104	100	Horn	
2		48.4	-63.7	9.5	5.5	-59.7	-13.0	46.7	Hori.	115	106	Horn	
3		48.5	-63.1	9.6	6.2	-59.7	-13.0		Hori.	121	60	Horn	
4	2774.986		-52.4	10.0	6.8	-49.2	-13.0		Hori.	100	65	Horn	
5			-64.7	11.4	7.4	-60.7	-13.0		Hori.	102	62	Horn	
6		49.7	-57.7	12.3	7.9	-53.3	-13.0	40.3	Hori.	107	64	Horn	
7			-65.5	12.3	8.4	-61.6	-13.0			100	62	Horn	
8		45.8	-61.6		8.9	-58.3	-13.0		Hori.	100	299	Horn	
9			-71.1	7.3	4.8	-68.6	-13.0		Vert.	149	293	Horn	
10		47.4	-66.4	9.5	5.5	-62.4	-13.0		Vert.	149	239	Horn	
11		47.4	-62.5	9.6	6.2	-59.1	-13.0		Vert.	109	62	Horn	
12			-55.5	10.0	6.8	-52.3	-13.0		Vert.	104	175	Horn	
13		47.6	-60.3	11.4	7.4	-56.3	-13.0		Vert.	147	64	Horn	
14		45.6	-67.5	12.3	7.9	-63.1	-13.0		Vert.	129	36	Horn	
15		44.1	-69.9	12.3	8.4	-66.0	-13.0		Vert.	133	47	Horn	
16	4624.977	43.4	-70.4	12.2	8.9	-67.1	-13.0	54.1	Vert.	130	0	Horn	
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DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.1 Semi-Anechoic Chamber Date : 2014/02/18

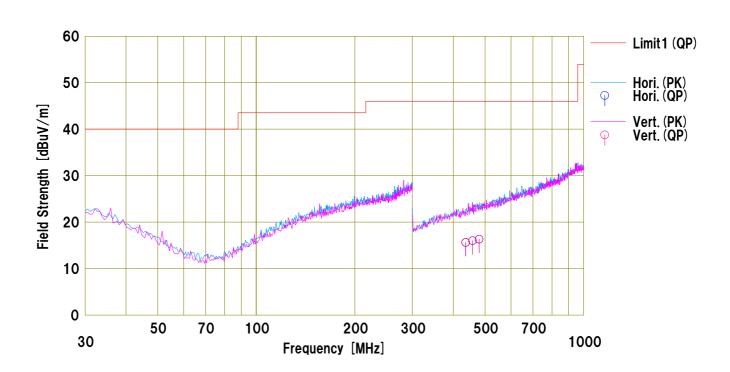
: Kenichi Adachi

Circuit Design, Inc. Mode

Company Kind of EUT Model No. Receiving 458.0000MHz 10214948S DC 5V UHF Narrow band multi channel transceiver Order No.

LMD-400-R Power 50000019 Temp./Humi. 21deg.C / 22%RH Serial No. EUT & antenna worst-axis: H: Z, V: X Remarks

Limit1: FCC 15B Class B (3m) **Engineer**



No.	Freq.	Reading <qp></qp>	Ant.Fac	Loss	Gain	Result <qp></qp>	Limit <qp></qp>	Margin <qp></qp>	Pola.	Height	Angle	Ant.	Comment
""	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]		[dBuV/m]	[dB]	[H/V]	[cm]	[deg]	Type	Common
1					31.9	15.6	46.0	30.4	Hori.	100	0	LP	
2	457.998					16.0				100		LP	
3	479.700					16.3				100		LP	
5	436.300 457.998					15.6 16.0				100 100		LP LP	
6						16.3				100		LP	
•	170.700	20.2	11.0	0.0	01.0	10.0	10.0	20.7			Ĭ		

DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.1 Semi-Anechoic Chamber Date : 2014/02/18

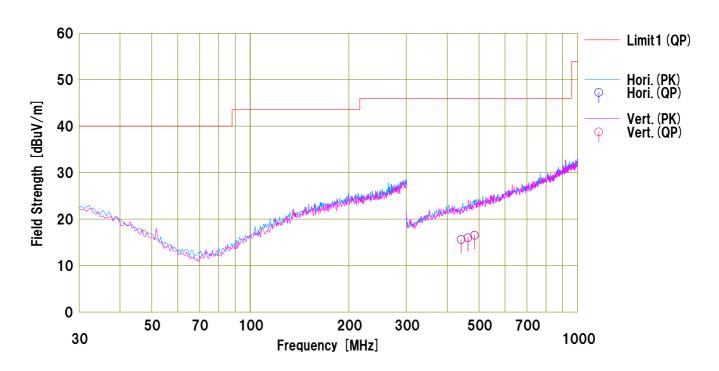
Mode

Company Kind of EUT Model No. Circuit Design, Inc. UHF Narrow band multi channel transceiver Receiving 462.5000MHz 10214948S DC 5V Order No.

LMD-400-R Power 50000019 Temp./Humi. 21deg.C / 22%RH Serial No. EUT & antenna worst-axis: H: Z, V: X Remarks

Limit1: FCC 15B Class B (3m)

: Kenichi Adachi **Engineer**



No.	Freq.	Reading <qp></qp>	Ant.Fac	Loss	Gain	Result <qp></qp>	Limit <qp></qp>	Margin <qp></qp>	Pola.	Height	Angle	Ant. Type	Comment
	[MHz]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[H/V]	[cm]	[deg]	Type	
1	440.800	23.1	16.6	7.8	31.9	15.6	46.0	30.4	Hori.	100	0	LP	
2					31.9	16.0	46.0			100		LP	
3					31.9	16.5				100		LP	
4						15.6				100		LP	
5					31.9	16.0				100		LP	
6	484.200	23.2	17.1	8.1	31.9	16.5	46.0	29.5	Vert.	100	0	LP	
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DATA OF RADIATED EMISSION TEST

Engineer

UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date : 2014/02/20

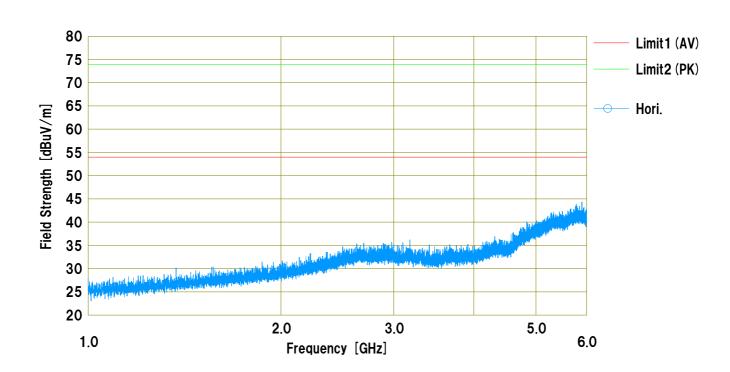
: Kenichi Adachi

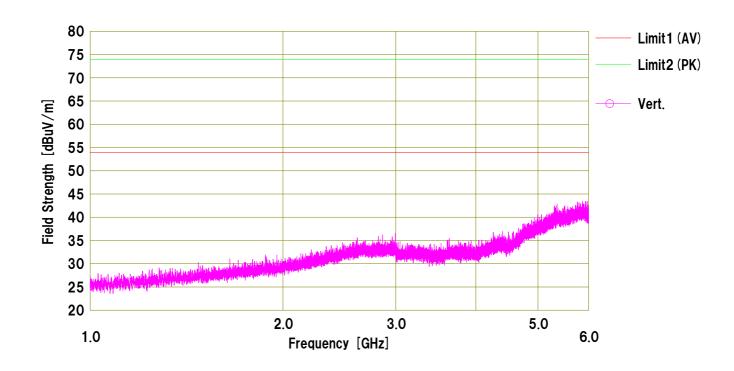
Mode

Company Kind of EUT Model No. Circuit Design, Inc. UHF Narrow band multi channel transceiver Receiving 458.0000MHz 10214948S DC 5V Order No. LMD-400-R Power

50000019 24deg.C / 21%RH Temp./Humi. Serial No. EUT & antenna worst-axis: H: Y, V: Z No detect signal from EUT Remarks

Limit1: FCC 15B Class B (3m) AV Limit2: FCC 15B Class B (3m) Peak





DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.2 Semi-Anechoic Chamber Date : 2014/02/19

Mode

Company Kind of EUT Model No. **Circuit Design, Inc.**UHF Narrow band multi channel transceiver LMD-400-R

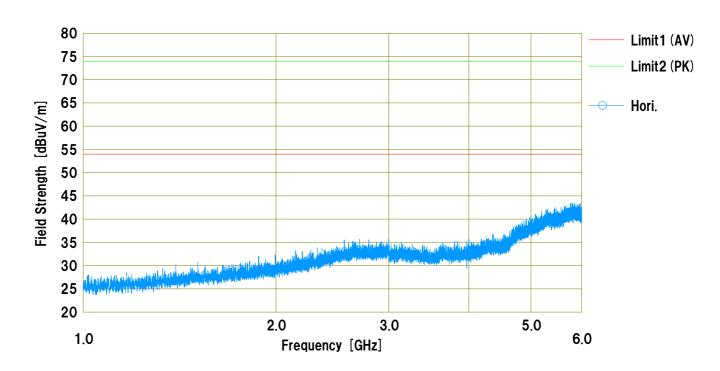
50000019 Serial No. EUT & antenna worst-axis: H: Y, V: Z No detect signal from EUT Remarks

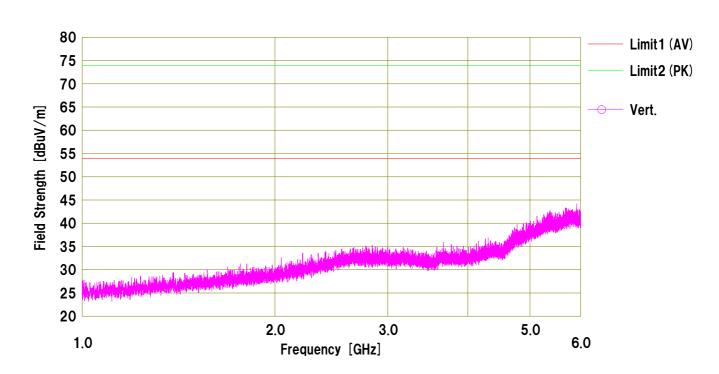
Receiving 462.5000MHz 10214948S DC 5V

Order No. Power

Temp./Humi. 24deg.C / 21%RH

Limit1: FCC 15B Class B (3m) AV Limit2: FCC 15B Class B (3m) Peak Engineer : Kenichi Adachi





Revised date : July 21, 2015

Frequency Stability

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded room

Company Circuit Design Inc. Regulation FCC part 90 subpart I, 90.213

RSS-119 section 5.3

Model LMD-400-R Date February 21, 2014

Serial No.S0000020Temperature25 deg.CPowerDC 5 VHumidity28 %RHModeTransmitting 458 MHzENGINEERKenichi Adachi

UHF Narrow Band Multi Channel Transceiver

Temperature Variation: -20deg.C

Equipment

* This limit is severer limit value is applied.

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996263	458.003950	458.000107	0.000107	0.23253	1.500
after 2minutes	458.0000	457.996200	458.004056	458.000128	0.000128	0.27948	1.500
after 5minutes	458.0000	457.996475	458.003619	458.000047	0.000047	0.10262	1.500
after 10minutes	458.0000	457.996481	458.003881	458.000181	0.000181	0.39520	1.500

Temperature Variation: -10deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996288	458.004100	458.000194	0.000194	0.42358	1.500
after 2minutes	458.0000	457.996518	458.003956	458.000237	0.000237	0.51747	1.500
after 5minutes	458.0000	457.996406	458.003981	458.000194	0.000194	0.42249	1.500
after 10minutes	458.0000	457.996488	458.003788	458.000138	0.000138	0.30131	1.500

Temperature Variation: 0deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996300	458.004075	458.000188	0.000188	0.40939	1.500
after 2minutes	458.0000	457.996175	458.004106	458.000141	0.000140	0.30677	1.500
after 5minutes	458.0000	457.995944	458.004100	458.000022	0.000022	0.04803	1.500
after 10minutes	458.0000	457.996568	458.003844	458.000206	0.000206	0.44978	1.500

Temperature Variation: 10deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996400	458.004082	458.000241	0.000241	0.52620	1.500
after 2minutes	458.0000	457.995956	458.004119	458.000038	0.000037	0.08188	1.500
after 5minutes	458.0000	457.996431	458.003888	458.000160	0.000159	0.34825	1.500
after 10minutes	458.0000	457.996488	458.004088	458.000288	0.000288	0.62882	1.500

Temperature Variation: 20deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996219	458.004050	458.000135	0.000135	0.29367	1.500
after 2minutes	458.0000	457.996294	458.004056	458.000175	0.000175	0.38210	1.500
after 5minutes	458.0000	457.996544	458.003794	458.000169	0.000169	0.36900	1.500
after 10minutes	458.0000	457.995912	458.004075	457.999994	-0.000007	-0.01419	1.500

^{*} calculation: Measure frequency = (Measure Low frequency + Measure High frequency) / $2\,$

UL Japan, Inc.

Shonan EMC Lab.

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Revised date : July 21, 2015

Frequency Stability

Temperature Variation: 30deg.C

* This limit is severer limit value is applied.

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996232	458.004100	458.000166	0.000166	0.36245	1.500
after 2minutes	458.0000	457.996212	458.004050	458.000131	0.000131	0.28603	1.500
after 5minutes	458.0000	457.996325	458.003894	458.000110	0.000110	0.23908	1.500
after 10minutes	458.0000	457.995900	458.004088	457.999994	-0.000006	-0.01310	1.500

Temperature Variation: 40deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996162	458.003668	457.999915	-0.000085	-0.18559	1.500
after 2minutes	458.0000	457.996144	458.003926	458.000035	0.000035	0.07642	1.500
after 5minutes	458.0000	457.996206	458.003925	458.000066	0.000066	0.14301	1.500
after 10minutes	458.0000	457.995787	458.003931	457.999859	-0.000141	-0.30786	1.500

Temperature Variation: 50deg.C

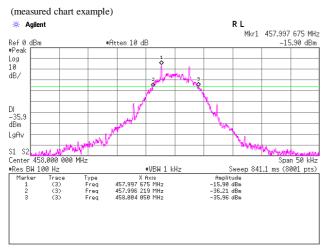
	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996132	458.003850	457.999991	-0.000009	-0.01965	1.500
after 2minutes	458.0000	457.996263	458.003732	457.999998	-0.000002	-0.00546	1.500
after 5minutes	458.0000	457.996132	458.003863	457.999998	-0.000002	-0.00546	1.500
after 10minutes	458.0000	457.996088	458.003863	457.999976	-0.000024	-0.05349	1.500

Temperature Variation: 60deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.995688	458.003838	457.999763	-0.000237	-0.51747	1.500
after 2minutes	458.0000	457.995694	458.003950	457.999822	-0.000178	-0.38865	1.500
after 5minutes	458.0000	457.996044	458.003856	457.999950	-0.000050	-0.10917	1.500
after 10minutes	458.0000	457.995712	458.003975	457.999844	-0.000157	-0.34170	1.500

^{*} calculation: Measure frequency = (Measure Low frequency + Measure High frequency) / 2

^{* -30} deg.C was not measured, because this test may be not applied since the RF output power of this equipment is less than 120 mW.



UL Japan, Inc.

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Revised date : July 21, 2015

Frequency Stability

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded room

Company Circuit Design Inc. Regulation FCC part 90 subpart I, 90.213

RSS-119 section 5.3

UHF Narrow Band Multi Channel Transceiver Equipment Model LMD-400-R Date February 21, 2014

S0000020 25 deg.C Serial No. Temperature Power DC 5 V Humidity 28 %RH

Transmitting 462.5 MHz **ENGINEER** Kenichi Adachi Mode

Temperature Variation: -20deg.C

* This limit is severer limit value is applied.

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.496200	462.504144	462.500172	0.000172	0.37189	1.500
after 2minutes	462.5000	462.496462	462.503581	462.500022	0.000022	0.04649	1.500
after 5minutes	462.5000	462.496500	462.503881	462.500191	0.000191	0.41189	1.500
after 10minutes	462.5000	462.496256	462.503732	462.499994	-0.000006	-0.01297	1.500

Temperature Variation: -10deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.495844	462.504106	462.499975	-0.000025	-0.05405	1.500
after 2minutes	462.5000	462.496406	462.503625	462.500016	0.000016	0.03351	1.500
after 5minutes	462.5000	462.496400	462.503937	462.500169	0.000168	0.36432	1.500
after 10minutes	462.5000	462.496532	462.503732	462.500132	0.000132	0.28541	1.500

Temperature Variation: 0deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.496162	462.504212	462.500187	0.000187	0.40432	1.500
after 2minutes	462.5000	462.496406	462.504050	462.500228	0.000228	0.49297	1.500
after 5minutes	462.5000	462.496393	462.504024	462.500209	0.000208	0.45081	1.500
after 10minutes	462.5000	462.496331	462.504224	462.500278	0.000278	0.60000	1.500

Temperature Variation: 10deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.495957	462.504244	462.500101	0.000101	0.21730	1.500
after 2minutes	462.5000	462.496269	462.504200	462.500235	0.000235	0.50703	1.500
after 5minutes	462.5000	462.496375	462.504119	462.500247	0.000247	0.53405	1.500
after 10minutes	462.5000	462.496431	462.504044	462.500238	0.000238	0.51351	1.500

Temperature Variation: 20deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.495919	462.503862	462.499891	-0.000110	-0.23676	1.500
after 2minutes	462.5000	462.495919	462.504157	462.500038	0.000038	0.08216	1.500
after 5minutes	462.5000	462.496300	462.503900	462.500100	0.000100	0.21622	1.500
after 10minutes	462.5000	462.495912	462.504069	462.499991	-0.000010	-0.02054	1.500

^{*} calculation: Measure frequency = (Measure Low frequency + Measure High frequency) / 2

UL Japan, Inc.

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Revised date : July 21, 2015

Frequency Stability

Temperature Variation: 30deg.C

* This limit is severer limit value is applied.

<u> </u>								
	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit	
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance		
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)	
startup	462.5000	462.496294	462.503781	462.500038	0.000037	0.08108	1.500	
after 2minutes	462.5000	462.496368	462.504012	462.500190	0.000190	0.41081	1.500	
after 5minutes	462.5000	462.495887	462.504025	462.499956	-0.000044	-0.09514	1.500	
after 10minutes	462.5000	462.496431	462.503787	462.500109	0.000109	0.23568	1.500	

Temperature Variation: 40deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.496144	462.503663	462.499904	-0.000096	-0.20865	1.500
after 2minutes	462.5000	462.495788	462.504057	462.499923	-0.000077	-0.16757	1.500
after 5minutes	462.5000	462.495782	462.504063	462.499923	-0.000077	-0.16757	1.500
after 10minutes	462.5000	462.496182	462.503782	462.499982	-0.000018	-0.03892	1.500

Temperature Variation: 50deg.C

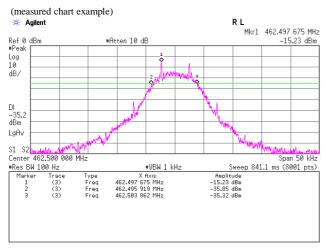
Temperature + arrayout & dauge o								
Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit		
Frequency	frequency	frequency	frequency	Error	torerance			
(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)		
462.5000	462.495719	462.503906	462.499813	-0.000188	-0.40541	1.500		
462.5000	462.496106	462.503693	462.499900	-0.000101	-0.21730	1.500		
462.5000	462.495688	462.503888	462.499788	-0.000212	-0.45838	1.500		
462.5000	462.495706	462.503982	462.499844	-0.000156	-0.33730	1.500		
	Frequency (MHz) 462.5000 462.5000 462.5000	Frequency (MHz) (MHz) 462.5000 462.495719 462.5000 462.496106 462.5000 462.495688	Frequency frequency frequency (MHz) (MHz) (MHz) (MHz) 462.5000 462.495719 462.503693 462.5000 462.496106 462.503693 462.5000 462.495688 462.503888	Frequency (MHz) frequency (MHz) frequency (MHz) frequency (MHz) 462.5000 462.495719 462.503906 462.499813 462.5000 462.496106 462.503693 462.499900 462.5000 462.495688 462.503888 462.499788	Frequency frequency frequency frequency (MHz) (MHz) (MHz) (MHz) (MHz) (MHz) (MHz) (MHz) (462.5000 462.495719 462.503906 462.499813 -0.000188 462.5000 462.496106 462.503693 462.499900 -0.000101 462.5000 462.495688 462.503888 462.499788 -0.000212	Frequency frequency frequency frequency Error torerance (MHz) (MHz) (MHz) (MHz) (MHz) (MHz) (ppm) 462.5000 462.495719 462.503906 462.499813 -0.000188 -0.40541 462.5000 462.496106 462.503693 462.499900 -0.000101 -0.21730 462.5000 462.495688 462.503888 462.499788 -0.000212 -0.45838		

Temperature Variation: 60deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.495675	462.503900	462.499788	-0.000212	-0.45946	1.500
after 2minutes	462.5000	462.495994	462.503994	462.499994	-0.000006	-0.01297	1.500
after 5minutes	462.5000	462.495706	462.503825	462.499766	-0.000235	-0.50703	1.500
after 10minutes	462.5000	462.496044	462.503625	462.499835	-0.000165	-0.35784	1.500

^{*} calculation: Measure frequency = (Measure Low frequency + Measure High frequency) / 2

^{* -30} deg.C was not measured, because this test may be not applied since the RF output power of this equipment is less than 120 mW.



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Revised date : July 21, 2015

Frequency Stability

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded room

Company Regulation FCC part 90 subpart I, 90.213 Circuit Design Inc.

RSS-119 section 5.3

Equipment UHF Narrow Band Multi Channel Transceiver Model LMD-400-R Date February 21, 2014

> Temperature 25 deg.C Humidity 28 %RH **ENGINEER** Kenichi Adachi

Voltage Variation: DC 3 V

Serial No.

Power

Mode

Temperature Variation: 20deg.C

S0000020

Transmitting 458 MHz

DC 5 V

* This limit is severer limit value is applied.

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996344	458.003694	458.000019	0.000019	0.04148	1.500
after 2minutes	458.0000	457.996225	458.004069	458.000147	0.000147	0.32096	1.500
after 5minutes	458.0000	457.996400	458.003894	458.000147	0.000147	0.32096	1.500
after 10minutes	458.0000	457.996250	458.004176	458.000213	0.000213	0.46507	1.500

Voltage Variation: DC 5 V

Temperature Variation: 20deg.C

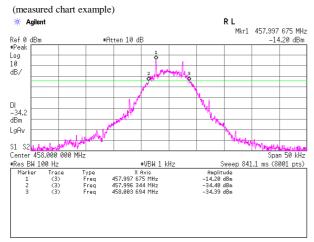
	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996219	458.004050	458.000135	0.000135	0.29367	1.500
after 2minutes	458.0000	457.996294	458.004056	458.000175	0.000175	0.38210	1.500
after 5minutes	458.0000	457.996544	458.003794	458.000169	0.000169	0.36900	1.500
after 10minutes	458.0000	457.995912	458.004075	457.999994	-0.000007	-0.01419	1.500

Voltage Variation: DC 5.5 V

Temperature Variation: 20deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	458.0000	457.996388	458.004025	458.000207	0.000206	0.45087	1.500
after 2minutes	458.0000	457.996318	458.004044	458.000181	0.000181	0.39520	1.500
after 5minutes	458.0000	457.996400	458.004044	458.000222	0.000222	0.48472	1.500
after 10minutes	458.0000	457.996388	458.004050	458.000219	0.000219	0.47817	1.500

^{*} calculation: Measure frequency = (Measure Low frequency + Measure High frequency) / 2



UL Japan, Inc.

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Revised date : July 21, 2015

Frequency Stability

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded room

Regulation FCC part 90 subpart I, 90.213 Company Circuit Design Inc.

RSS-119 section 5.3

Equipment UHF Narrow Band Multi Channel Transceiver Model LMD-400-R Date February 21, 2014

S0000020 Serial No. Temperature 25 deg.C Power DC 5 V Humidity 28 %RH Mode Transmitting 462.5 MHz **ENGINEER** Kenichi Adachi

Voltage Variation: DC 3 V

Temperature Variation: 20deg.C

* This limit is severer limit value is applied.

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.496300	462.504025	462.500163	0.000162	0.35135	1.500
after 2minutes	462.5000	462.495912	462.504106	462.500009	0.000009	0.01946	1.500
after 5minutes	462.5000	462.496475	462.503881	462.500178	0.000178	0.38486	1.500
after 10minutes	462.5000	462.496362	462.503725	462.500044	0.000043	0.09405	1.500

Voltage Variation: DC 5 V

Temperature Variation: 20deg.C

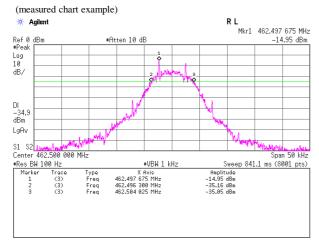
	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.495919	462.503862	462.499891	-0.000110	-0.23676	1.500
after 2minutes	462.5000	462.495919	462.504157	462.500038	0.000038	0.08216	1.500
after 5minutes	462.5000	462.496300	462.503900	462.500100	0.000100	0.21622	1.500
after 10minutes	462.5000	462.495912	462.504069	462.499991	-0.000010	-0.02054	1.500

Voltage Variation: DC 5.5 V

Temperature Variation: 20deg.C

	Original	Measure Low	Measure High	Measure	Frequency	Frequency	Limit
Test Conditions	Frequency	frequency	frequency	frequency	Error	torerance	
	(MHz)	(MHz)	(MHz)	(MHz)	(MHz)	(ppm)	(ppm)
startup	462.5000	462.496312	462.504056	462.500184	0.000184	0.39784	1.500
after 2minutes	462.5000	462.496244	462.504168	462.500206	0.000206	0.44541	1.500
after 5minutes	462.5000	462.496288	462.503894	462.500091	0.000091	0.19676	1.500
after 10minutes	462.5000	462.495919	462.504112	462.500016	0.000016	0.03351	1.500

^{*} calculation: Measure frequency = (Measure Low frequency + Measure High frequency) / 2



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APPENDIX 2 Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SBA-01	Biconical Antenna	Schwarzbeck	BBA9106	91032664	RE	2013/10/13 * 12
KAT6-04	Attenuator	INMET	18N-6dB	-	RE	2013/12/26 * 12
SCC-A1/A3/A5 /A7/A8/A13/S RSE-01	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906		RE	2013/04/04 * 12
SLA-01	Logperiodic Antenna	Schwarzbeck	UHALP9108A	UHALP 9108-A 0888	RE	2013/10/26 * 12
KAT3-09	Attenuator	JFW IND. INC.	50HF-003N	-	RE	2013/08/23 * 12
SCC-A2/A4/A6 /A7/A8/A13/S RSE-01	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906	-/0901-269(RF Selector)	RE	2013/04/04 * 12
SAT10-01	Attenuator	JFW	50HF-010N	_	RE	2014/02/17 * 12
SAF-01	Pre Amplifier	SONOMA	310N	290211	RE	2014/02/17 * 12
STR-01	Test Receiver	Rohde & Schwarz	ESU40	100093	RE	2013/11/20 * 12
SOS-02	Humidity Indicator	A&D	AD-5681	4063343	RE	2013/03/07 * 12
SJM-08	Measure	PROMART	SEN1935	_	RE	_
SAEC-01(NSA)	Semi-Anechoic Chamber	TDK	SAEC-01(NSA)	1	RE	2013/07/03 * 12
	EMI Software	TSJ	TEPTO-DV(RE,CE, RFI,MF)	_	RE	_
STM-06	Terminator	TME	CT-01 BP	_	RE	2013/12/26 * 12
SSG-02	Signal Generator	Agilent	E8257D-540	MY48051404	RE	2013/03/29 * 12
SCC-04	Coaxial Cable	Fujikura	5D2W	-	RE	2013/09/03 * 12
SCC-05	Coaxial Cable	Fujikura	5D2W	-	RE	2013/04/03 * 12
SDA-08	Dipole Antenna	Schwarzbeck	UHAP	1158	RE	2013/03/29 * 12
SHA-01	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-725	RE	2013/08/12 * 12
SCC-G01	Coaxial Cable	Suhner	SUCOFLEX 104A	46497/4A	RE	2013/04/09 * 12
SAF-04	Pre Amplifier	TOYO Corporation	TPA0118-36	1440489	RE	2013/03/19 * 12
SCC-G21	Coaxial Cable	Suhner	SUCOFLEX 104	296169/4	RE	2013/05/22 * 12
SHA-02	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-726	RE	2013/08/12 * 12
SCC-G02	Coaxial Cable	Suhner	SUCOFLEX 104A	46498/4A	RE	2013/04/09 * 12
KAF-04	Pre Amplifier	Agilent	8449B	3008A01600	RE	2013/04/03 * 12
SCC-G22	Coaxial Cable	Suhner	SUCOFLEX 104	296199/4	RE	2013/05/22 * 12
SSA-01	Spectrum Analyzer	Agilent	N9010A-526	MY48031482	RE	2013/04/09 * 12
SOS-04	Humidity Indicator	A&D	AD-5681	4061512	RE	2013/03/07 * 12
SJM-02	Measure	KOMELON	KMC-36	-	RE	-
SAEC-02(NSA)	Semi-Anechoic Chamber	TDK	SAEC-02(NSA)	2	RE	2013/07/06 * 12
SCC-G16	Coaxial Cable	Suhner	SUCOFLEX 102	32704/2	RE	2013/03/16 * 12
SHA-RS01	Horn Antenna	Schwarzbeck	BBHA9120D	770	RE	2013/08/19 * 12
SLP-02	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100218	RE	2013/11/08 * 12
SAT6-07	Attenuator	JFW	50HF-006N	-	RE	2014/02/17 * 12
SCC-B2/B4/B6 /B7/B8/B13/S RSE-02		Fujikura/Fujikura/Suhne r/Suhner/Suhner/Suhn er/TOYO	8D2W/12DSFA/14 1PE/141PE/141PE /141PE/NS4906	-/0901-270(RF Selector)	RE	2013/04/03 * 12
SAF-02	Pre Amplifier	SONOMA	310N	290212	RE	2014/02/17 * 12
STR-02	Test Receiver	Rohde & Schwarz	ESCI	100575	RE	2013/09/24 * 12

The expiration date of the calibration is the end of the expired month . As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards .

Test Item: RE: Radiated emission, AT: Antenna terminal conducted tests,

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APPENDIX 2 Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SPM-06	Power Meter	Anritsu	ML2495A	0850009	AT	2013/04/09 * 12
SPSS-01	Power Sensor	Anritsu	MA2444D	0738366	AT	2013/04/09 * 12
SFC-01	Microwave Counter	Agilent	53151A	US40511493	AT	2013/03/26 * 12
SSA-03	Spectrum Analyzer	Agilent	E4448A	MY48250152	AT	2014/02/03 * 12
SAT20-06	Attenuator	Weinschel Corp.	54A-20	31506	AT	2013/04/09 * 12
SCC-G13	Coaxial Cable	Suhner	SUCOFLEX 102	31599/2	AT	2013/03/16 * 12
SOS-09	Humidity Indicator	A&D	AD-5681	4061484	AT	2013/03/07 * 12
STS-05	Digital Hitester	Hioki	3805-50	080997828	AT	2013/03/25 * 12
SCH-01	Temperature and Humidity Chamber	Espec	PL-1KT	14020837	AT	2013/04/17 * 12

The expiration date of the calibration is the end of the expired month . As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards.

Test Item:

RE: Radiated emission,

AT: Antenna terminal conducted tests,

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